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	(Use several sheets if necessary) (37 CFR (98(b))		Filing Date January 2, 2001	Group Art Unit 2644	

				Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	Foreign Patent Documents or Published Foreign Patent Applications							
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	Other Documents (include Author, Title, Date, and Place of Publication)					
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